

CERTIFICATE OF ANALYSIS

83X PR3 (batch G)

Certified Reference Material Information

Type: LEAD WITH IMPURITIES (CAST)
Form and Size: Disc ~40mm diameter
Produced by: Universal Scientific Laboratory Pty Ltd
Certified and supplied by: MBH Analytical Ltd

Assigned Values

Percentage element by weight

Element	Sn	Sb	Bi	Cu	Cd	As	Ni	Se
Value ¹	0.0417	0.0888	0.144	0.0694	0.0462	0.0011	0.0116	0.0166
Uncertainty ²	0.0011	0.0012	0.003	0.0008	0.0013	0.0002	0.0009	0.0008

Element	Ag	Te	Tl	In	Au	Zn	Na	Hg
Value ¹	0.0029	0.0039	0.0033	0.0093	0.0036	(0.0007)	(0.0038)	0.0008
Uncertainty ²	0.0002	0.0001	0.0002	0.0008	0.0002	-	-	0.0001

Note: values given in parentheses are not certified - they are provided for information only.

Definitions

- ¹ The certified values are the present best estimates of the true content for each element. Each value is a panel consensus, based on the averaged results of an interlaboratory testing programme, detailed on page 3.
- ² The uncertainty values are generated from the 95% confidence interval derived from the wet analysis results, in combination with a statistical assessment of the homogeneity data, as described on page 2.

Certified by:

MBH ANALYTICAL LIMITED _____

on 30th November 2017

C Eveleigh

Method of Preparation

This reference material was produced from commercial refined lead to UNS L50010; the trace elements were added as single elements or as binary alloys. The melt was cast by sequential transfer of aliquots into iron moulds. 2mm has been removed from the working face to minimise any surface effects.

Sampling

Samples for chemical analysis were taken from various positions throughout the casting process. Approximately 10% of all discs were selected for non-destructive homogeneity testing.

Homogeneity

The discs were checked for sample and batch uniformity using an optical emission spectrometer.

Using the combined data for each surface, through-batch variation values were derived for each element as an indicator of any minor compositional variation (as determined for the specific sample size and other limitations of the spectrometer).

Chemical Analysis

Analysis was carried out on millings taken from samples representative of the product. It was performed by a panel of laboratories mostly operating within the terms of EN ISO/IEC 17025, using documented standard reference methods and validated by appropriate reference materials.

The individual values listed overpage are the average of each analyst's results.

Estimation of Uncertainties

Each element certified has been analysed by several laboratories, and 95% half-width confidence intervals ($C_{(95\%)}$) for the resultant mean values have been derived by the method shown on page 3.

As a separate exercise, the degree of non-homogeneity of the batch for each element has been quantified by a programme of non-destructive application testing, discussed above.

The final certified uncertainty for each element has been derived by combining these two factors, using the square-root of the summed squares.

Traceability

Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials.

Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

Usage

Intended use: With optical emission and X-ray fluorescence spectrometers.

Recommended method of use: Lead and its alloys are generally prepared by machining on a lathe. However, users are recommended to follow the calibration and sample preparation procedures specified by the relevant instrument manufacturer.

Preparation should be the same for reference materials and the samples for test.

A minimum of five consistent replicate analyses is recommended to provide the necessary sample size. Users are advised to check against possible bias between reference materials and production samples due to differences in metallurgical history, and be aware of possible inter-element effects.

Analytical Data

Percentage element by weight

Sample	Sn	Sb	Bi	Cu	Cd	As	Ni	Se
1	0.0384	0.0856	0.1391	0.0669	0.0437	0.00062	0.0101	0.0143
2	0.0387	0.0864	0.1395	0.0677	0.0440	0.00070	0.0102	0.0144
3	0.0396	0.0875	0.1400	0.0684	0.0442	0.00070	0.0107	0.0146
4	0.0403	0.0880	0.1403	0.0685	0.0442	0.00094	0.0108	0.0155
5	0.0406	0.0887	0.1404	0.0685	0.0445	0.00100	0.0108	0.0156
6	0.0408	0.0889	0.1410	0.0688	0.0454	0.00103	0.0111	0.0162
7	0.0418	0.0893	0.1427	0.0688	0.0458	0.00110	0.0112	0.0165
8	0.0420	0.0893	0.1440	0.0690	0.0461	0.00116	0.0113	0.0168
9	0.0421	0.0901	0.1469	0.0691	0.0464	0.00118	0.0118	0.0169
10	0.0422	0.0905	0.1486	0.0695	0.0466	0.00120	0.0120	0.0171
11	0.0423	0.0908	0.1490	0.0698	0.0468	0.00124	0.0122	0.0171
12	0.0427	0.0910	0.1510	0.0711	0.0469	0.00140	0.0122	0.0171
13	0.0434		0.1524	0.0713	0.0471	0.00165	0.0124	0.0172
14	0.0439			0.0715	0.0480		0.0126	0.0177
15	0.0440			0.0719	0.0483		0.0126	0.0184
16	0.0448				0.0484		0.0126	0.0184
17					0.0488		0.0127	0.0186
Mean	0.0417	0.0888	0.1442	0.0694	0.0462	0.00107	0.0116	0.0166
Std Dev	0.0019	0.0017	0.0048	0.0015	0.0017	0.00029	0.0009	0.0014
C_(95%)	0.0010	0.0011	0.0029	0.0008	0.0009	0.00018	0.0005	0.0007

Sample	Ag	Te	Tl	In	Au	Zn	Na	Hg
1	0.00258	0.00340	0.00293	0.00820	0.00313	0.00041	0.00231	0.00056
2	0.00260	0.00370	0.00310	0.00838	0.00320	0.00044	0.00251	0.00070
3	0.00264	0.00377	0.00320	0.00860	0.00327	0.00054	0.00287	0.00071
4	0.00272	0.00380	0.00328	0.00866	0.00340	0.00060	0.00340	0.00075
5	0.00274	0.00380	0.00330	0.00885	0.00346	0.00061	0.00350	0.00075
6	0.00275	0.00380	0.00332	0.00892	0.00359	0.00068	0.00370	0.00080
7	0.00276	0.00380	0.00342	0.00900	0.00360	0.00070	0.00380	0.00083
8	0.00280	0.00390	0.00350	0.00920	0.00367	0.00070	0.00421	0.00100
9	0.00300	0.00390	0.00370	0.00930	0.00380	0.00072	0.00470	0.00100
10	0.00300	0.00393		0.00974	0.00387	0.00072	0.00510	
11	0.00310	0.00395		0.00982	0.00390	0.00082	0.00520	
12	0.00330	0.00396		0.00995	0.00410	0.00083		
13	0.00340	0.00410		0.01020	0.00428	0.00090		
14	0.00350	0.00420		0.01028		0.00098		
15		0.00430		0.01060		0.00100		
Mean	0.00292	0.00389	0.00331	0.00931	0.00364	0.00071	0.00375	0.00079
Std Dev	0.00030	0.00021	0.00022	0.00074	0.00035	0.00018	0.00098	0.00014
C_(95%)	0.00017	0.00012	0.00017	0.00041	0.00021	0.00010	0.00066	0.00011

Note: C_(95%) is the 95% half-width confidence interval derived from the equation:

$$C_{(95\%)} = (t \times SD) / \sqrt{n}$$

where n is the number of available values, t is the Student's t value for n-1 degrees of freedom, and SD is the standard deviation of the test results.

Participating Laboratories

Sheffield Analytical Services
Anchorcert Analytical
Universal Scientific Laboratory Pty Ltd
Shanghai Jinyi Test Tech Co
Luo Yang Copper
Raghavendra SpectroMet Laboratory
Institute of Non-Ferrous Metals
Tec-Eurolab
TCR Engineering Services Ltd
INCDMNR-IMNR
AMG Superalloys UK Ltd
Coleshill Laboratories Ltd
AIM Metals and Alloys LP
Laboratory Inppamet
Analyticka Laborator Lithea sro
Johnson Controls Main Laboratory
Johnson Controls Plant Laboratory

Sheffield, England
Birmingham, England
Milperra, NSW, Australia
Shanghai, China
Luo Yang, He Nan, China
Bangalore, India
Gliwice, Poland
Campogalliano, Italy
Mumbai, India
Pantelimon, Romania
Rotherham, England
Coleshill, England
Montreal, Canada
Calama, Chile
Brno, Czech Republic
Hannover, Germany
Hannover, Germany

UKAS accreditation 0012
UKAS accreditation 0667
NATA accreditation 0492
CNAS accreditation L0041
CNAL accreditation 0173
NABL accreditation T371
PCA accreditation AB274
ACCREDIA accreditation 52

Note: to achieve the above accreditation (UKAS, etc), test houses must demonstrate conformity to the general requirements of EN ISO/IEC 17025.

Analytical Methods Used

ELEMENT	RESULT No. & METHOD			
	ICP-AES	ICP-MS	FAAS	OTHER
Tin	1, 3, 4, 6, 8-13, 15, 16	2	7, 14	5 photometric (phenyl fluorone)
Antimony	3-7, 9-12		1, 2, 8	
Bismuth	2-4, 7-11, 13		1, 5, 6, 12	
Copper	2-4, 6-13, 15	14	1, 5	
Cadmium	2, 4-11, 13, 14, 16	15	1, 3, 12, 17	
Arsenic	1-3, 5, 6, 8-10, 12, 13	4	7	11 photometric (molybdenum blue)
Nickel	1-7, 9-11, 13, 14	15	8, 12, 16, 17	
Selenium	1, 2, 4-6, 8, 9, 11-13, 15-17	3	7, 10, 14	
Silver	1, 2, 4, 5, 8, 10, 11, 13, 14		3, 6, 7, 9, 12	
Tellurium	1-3, 6-15		4, 5	
Thallium	1-6, 8, 9	7		
Indium	1-5, 7-9, 12-14		6, 10, 11, 15	
Gold	1-4, 6-8, 10, 12	13	5, 9, 11	
Zinc	1, 3, 4, 6-8, 10, 11, 13-15		2, 5, 9, 12	
Sodium	3, 5, 7-9, 11	2	1, 4, 6, 10	
Mercury	1-3, 5, 7-9	6	4	

Notes

This Certified Reference Material has been produced and certified in accordance with the requirements of ISO Guide 34, ISO Guide 31 and ISO Guide 35, taking into account the requirements of the ISO Guide to the Expression of Uncertainty in Measurement (GUM).

The unidirectional solidification effects associated with this method of casting have led to the formation of inhomogeneous segregates in the rear portion of the disc. The above certification is therefore only applicable from the front face of the disc, to a depth of 12mm. Material to the rear of the disc, to a depth of ~3mm, is not certified.

This material is liable to superficial corrosion. There is also a possibility for microstructural changes due to recrystallisation, and diffusion effects may lead to the concentration of some elements at the surface. For X-ray and other superficial sampling techniques, it is therefore recommended that the surface is refreshed immediately prior to use. In all other respects, this sample will remain stable indefinitely, provided adequate precautions are taken to protect it from cross-contamination, extremes of temperature and atmospheric moisture.

All production records will be retained for a period of 20 years from the date of this certificate. Technical support for this certification will therefore expire in November 2037, although we reserve the right to make changes as issue revisions, in the intervening period.

This sample is also available in the form of chippings. The manufacture, analysis and certification of this product were supervised by C Eveleigh, PhD, Technical Director, MBH Analytical Ltd.

The material to which this certificate of analysis refers is supplied subject to our general conditions of sale.